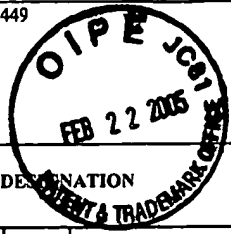


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	APPLICANT	MAMITSU et al.		
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TRANSLATION

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- Full English text is available in machine-translated form in JPO (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

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EXAMINER	<i>[Signature]</i>	DATE CONSIDERED	<i>3/17/05</i>
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